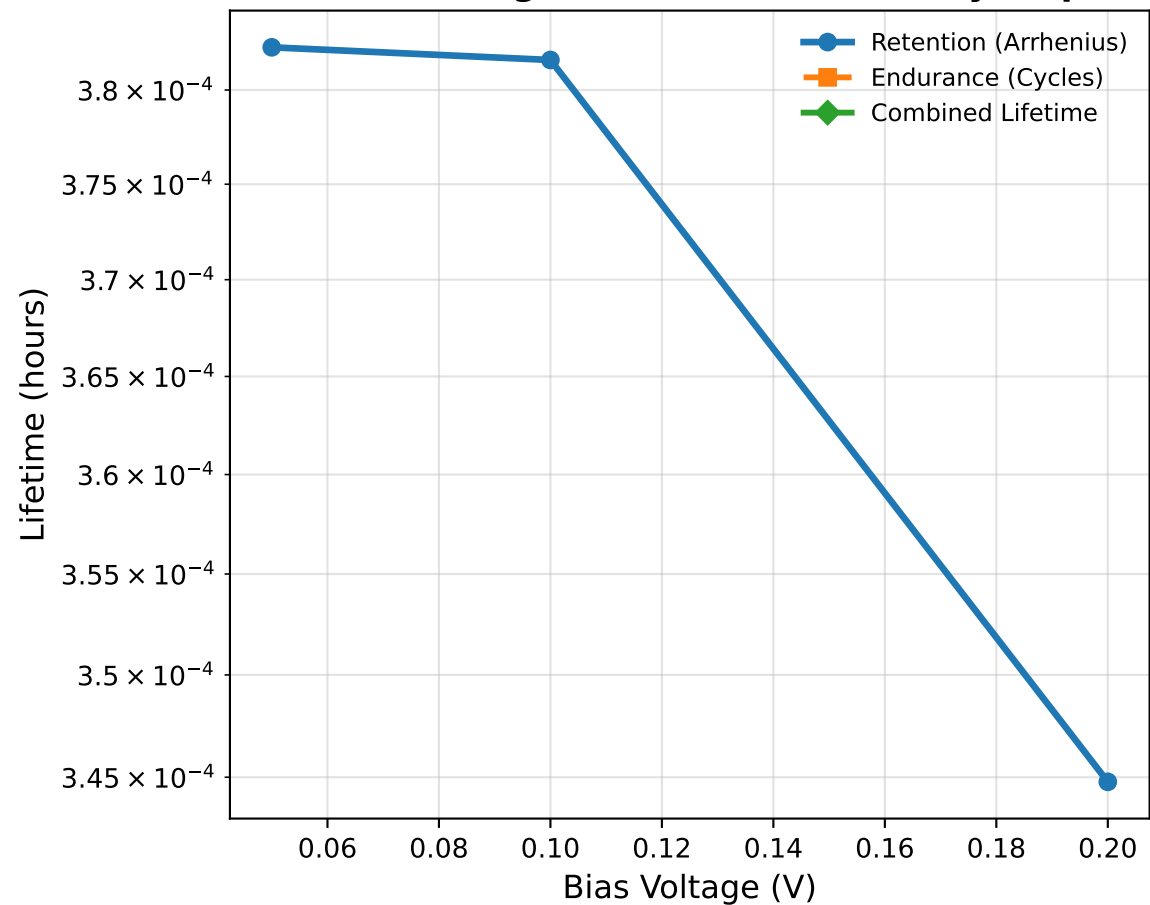


Self-Heating Accelerated Reliability Map



Bias-Induced Lifetime Acceleration

